

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination		
		10/730,322	KATOH ET AL.	
Examiner	Art Unit			
Shih-Chao Chen	2821			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
343	702	8/15/2005	CHEN
343	700MS	8/15/2005	CHEN